Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/769,293	HINO ET AL.	
Examiner	Art Unit	
Seung H. Lee	2876	

	SEAR	CHED	
Class	Subclass	Date	Examiner
			•
1			
		•	· · · · · · · · · · · · · · · · · · ·
	,		
-			

INT	ERFERENC	CE SEARCH	IED		
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (updated)	10/10/2005	SHL		
·				
	,			